

DESCRIPTION

MULTIMODE DIELECTRIC RESONATOR DEVICE, DIELECTRIC FILTER,
COMPOSITE DIELECTRIC FILTER AND COMMUNICATION APPARATUS

5 Technical Field

This invention relates to a dielectric resonator device operating in a multimode, and a dielectric filter, a composite dielectric filter and a communication apparatus which include the same.

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Background Art

Previously, Japanese Unexamined Patent Application Publication No. 11-145704 has disclosed a multimode dielectric resonator device having a dielectric core
15 disposed in a cavity and using a plurality of TM modes and TE modes.

In this multimode dielectric resonator device, when coupling is performed between predetermined modes by the shape of the dielectric core, perturbation on an electric
20 field is performed by providing a groove or a hole at a portion on which electric fields to be coupled are concentrated in order to exchange energy between the resonance modes, thereby the coupling is performed.

However, in a known multimode dielectric resonator
25 device, there has been a problem in that coupling is also

produced between the TM mode and the TM mode at the same time even if the shape of the dielectric core is determined only by paying attention to the portion on which two modes of electric fields to be coupled are concentrated in order
5 to perform the coupling between the TE mode and the TE mode.

For example, when coupling is performed between an TE_{01δ_x} mode in which an electric field is rotated in a plane perpendicular to an x-axis and an TE_{01δ_y} mode in which an electric field is rotated in a plane perpendicular
10 to a y-axis in an x-y-z rectangular cartesian coordinate system, a groove and a hole are provided at the portions through which the electric flux of an even mode and an odd mode, which are a coupling mode of both modes, pass in order to make a difference between the resonant frequencies of the
15 even mode and the odd mode. Thereby, it is possible to couple the two TE modes described above with each other.

However, the groove and the hole described above cause perturbation to arise between an TM_{01δ-x} mode in which an electric field is directed in an x direction and an TM_{01δ-y}
20 mode in which an electric field is directed in a y direction, and thus these two TM modes are coupled with each other. That is to say, in a multimode dielectric resonator using both the TM mode and the TE mode, when the coupling between the TE mode and the TE mode is performed, the coupling
25 between the TM mode and the TM mode is also caused to arise,

and thus it is difficult to independently determine the amount of coupling between the TE mode and the TE mode.

Also, if a dielectric core is provided with a groove or has a shape with a protruding part in order to perform
5 coupling between the TE mode and the TE mode, the shape of the electric flux distribution is disarranged. As a result, the frequency of the basic mode increases or decreases. Thus, there has been a problem in that when a filter is constructed by coupling a plurality of resonant modes in
10 sequence, the difficulty in adjusting the filter characteristics thereof increases.

Accordingly, an object of this invention is to provide a multimode dielectric resonator device which couples two TE modes, whose electric-field rotating planes have a
15 perpendicular relationship, independently of the coupling between two TM modes whose electric-field directions have the same perpendicular relationships, respectively.

Also, another object of this invention is to couple the TE modes themselves while avoiding coupling of the TM modes
20 having the relationship described above and to provide a multimode dielectric resonator device equipped with four-stage resonators of TM-mode-TE-mode-TE-mode-TM-mode by coupling the TM mode and the TE mode of the one side and coupling the TM mode and the TE mode of the other side, and
25 furthermore another object of this invention is to provide a

dielectric filter, a composite dielectric filter, and a communication apparatus including the above-described device.

Disclosure of Invention

5 According to this invention, there is provided a multimode dielectric resonator device having a dielectric core disposed in a cavity, for producing a first TM_{01δ} mode or TM₀₁₁ mode having an electric field directed in a first direction, a second TM_{01δ} mode or TM₀₁₁ mode having an
10 electric field directed in a second direction perpendicular to the first direction, a first TE_{01δ} mode having an electric field rotated in a plane perpendicular to the first direction, and a second TE_{01δ} mode having an electric field rotated in a plane perpendicular to the second direction,
15 respectively,

 wherein the effective dielectric constants of individual dielectric core portions having electric flux of an even-mode and an odd-mode of TE coupling mode in the first and the second TE_{01δ} modes passing through are
20 different from each other, and the effective dielectric constants of individual dielectric core portions having electric flux of an even-mode and an odd-mode of TM coupling mode in the first and the second TM_{01δ} mode or TM₀₁₁ mode passing through are substantially equal.

25 Accordingly, a difference in frequency arises between

the even-mode and the odd-mode, which are two coupling modes of the first and the second TE_{01δ} modes, and thus the first and the second TE_{01δ} modes are coupled. Also, no difference in frequency arises between the even-mode and the odd-mode, which are two coupling modes of the first and the second TM_{01δ} modes or TM₀₁₁ modes, and thus the first and the second TM_{01δ} modes or TM₀₁₁ modes are not coupled with each other. That is to say, the coupling between the first and the second TE_{01δ} modes can be set independently from the coupling of TM_{01δ} or TM₀₁₁ modes.

Also, in this invention, there is provided a difference in the amount of protrusion or the amount of subsidence in the dielectric core portions having electric flux passing therethrough with regard to the even mode and odd mode of the TE coupling mode, and a subsidence or protrusion for canceling frequency changes of the even mode and the odd mode of the TM coupling mode, by said difference of the amount of the protrusion or the amount of the subsidence, is disposed on the dielectric core portion of said TE coupling mode having a relatively small electric flux density.

With this structure, a frequency change in the even mode and the odd mode of the TM coupling mode, which arises by the difference in the amount of protrusion or the amount of subsidence of the dielectric core disposed on the position having a high electric flux density of the TE

coupling mode, is canceled, and thus the coupling between the first and the second TM01 δ modes or TM011 modes can be prevented.

Also, there is provided according to this invention a
5 multimode dielectric resonator device equipped with four-stage resonators having a first TM01 δ mode or TM011 mode, a first TE01 δ mode, a second TE01 δ mode, and a second TM01 δ mode or TM011 mode by coupling the first and the second TE01 δ modes with the first and the second TM01 δ modes or
10 TM011 modes, respectively, by displacing a center of electric flux density distribution of the first and the second TM01 δ modes or the first and the second TM011 modes upward or downward in planes perpendicular to the directions of the electric fields of the first and the second TM01 δ
15 modes or the first and the second TM011 modes.

In this manner, the first and the second TM01 δ modes or TM011 modes and the first and the second TE01 δ modes are coupled, respectively, by displacing a center of electric flux density distribution of the first and the second TM01 δ
20 modes or the first and the second TM011 modes upward or downward in planes perpendicular to the directions of the electric fields of the first and the second TM01 δ modes or the first and the second TM011 modes. At this time, the coupling does not arise between the first and the second
25 TM01 δ modes or the TM011 modes themselves, and thus an

operation is performed as four-stage resonators in which the first TM01 δ mode or TM011 mode→the first TE01 δ mode→the second TE01 δ mode→the second TM01 δ mode or TM011 mode are coupled in sequence.

5 Also, according to this invention, there is provided a dielectric filter including: a multimode dielectric resonator device operating as four-stage resonators described above; and external coupling means for external coupling in the first-stage and the last-stage resonators,
10 respectively, of the four-stage resonators.

Thereby, a filter including a band-pass characteristic including four-stage resonators operation is performed.

Also, there is provided according to this invention a composite dielectric filter including two sets of the
15 dielectric filters described above, sharing one of the external coupling means of each of the dielectric filters.

For example, an operation is performed as a transmitter/receiver by using one of the filters as a transmission filter, the other of the filters as a reception
20 filter, and the shared external coupling means as an antenna port.

Also, according to this invention, there is provided a communication apparatus equipped with the above-described dielectric filter or composite dielectric filter in its
25 high-frequency circuit portion.

Brief Description of the Drawings

Fig. 1 is a diagram illustrating directions of electric flux and magnetic flux of four resonant modes in the multimode dielectric resonator device according to a first embodiment. Fig. 2 is a diagram illustrating directions of the passing electric flux of each mode of the same dielectric resonator device. Fig. 3 is a diagram illustrating directions of the passing electric flux of each mode in a state in which a dielectric core 1 is contacted with the inner surface of a cavity 2. Fig. 4 is a diagram illustrating examples of the distribution of electric flux densities in the four resonant modes. Fig. 5 is a diagram illustrating a coupling sequence of the four resonant modes. Fig. 6 is a diagram illustrating a cross-sectional shape of each layer of the dielectric core in the cavity. Fig. 7 is a diagram illustrating the effect of a protrusion of the TE coupling on an TE coupling mode and an TM coupling mode. Fig. 8 is a diagram illustrating a relationship between the amount of protrusion of a protrusion portion P disposed in the dielectric core 1 and the resonant frequency and the coupling factor of each mode. Fig. 9 is a diagram illustrating relationships between the amount of protrusion of a protrusion portion P and the amount of subsidence of a subsidence portion S disposed in the dielectric core 1. Fig.

10 is a diagram illustrating the configuration of a dielectric filter. Fig. 11 is a diagram illustrating the configuration of a dielectric filter according to a second embodiment. Fig. 12 is a diagram illustrating the configuration of a dielectric filter according to a third embodiment. Fig. 13 is a diagram illustrating the configuration of another dielectric filter according to the third embodiment. Fig. 14 is a diagram illustrating the configuration of a dielectric filter according to a fourth embodiment. Fig. 15 is a diagram illustrating the configuration of another dielectric filter according to the fourth embodiment. Fig. 16 is a diagram illustrating the configuration of a dielectric filter according to a fifth embodiment. Fig. 17 is a diagram illustrating the configuration of another dielectric filter according to the fifth embodiment. Fig. 18 is a diagram illustrating the configuration of a dielectric filter according to a sixth embodiment. Fig. 19 is a diagram illustrating the configuration of a dielectric filter according to a seventh embodiment. Fig. 20 is a diagram illustrating the configuration of a dielectric filter according to an eighth embodiment. Fig. 21 is a diagram illustrating the configuration of a composite dielectric filter according to a ninth embodiment. Fig. 22 is a block diagram illustrating the configuration of a communication apparatus according to

a tenth embodiment.

Best Mode for Carrying Out the Invention

A description will be given of a multimode dielectric
5 resonator device according to a first embodiment with
reference to Figs. 1 to 10.

The material of the dielectric core disposed in the
devices shown in each embodiment including this first
embodiment is selected in accordance with the frequency band
10 used for the device. For example, a selection is made from
groups including zirconium titanate-stannum titanate series
compounds, rare-earth barium titanate series compounds,
barium titanate series compounds, zinc barium tantalate
series compounds, magnesium barium tantalate series
15 compounds, rare earth aluminate -calcium titanate series
compounds, magnesium titanate-calcium titanate series
compounds. The relative dielectric constant at this time
has an arbitrary value between 20 to 130. A zirconium
titanate-stannum titanate compound having a relative
20 dielectric constant of 38 is used in this first embodiment
and the other embodiments shown subsequently.

Fig. 1 is a perspective view showing a dielectric core
disposed in a cavity and the shapes of four resonant modes
to be used. A solid-line arrow in the figure indicates a
25 line of electric force and a broken-line arrow indicates a

line of magnetic force. (A) $TM_{01\delta_x}$ mode, which is the first $TM_{01\delta}$ mode, (B) $TE_{01\delta_y}$ mode, which is the first $TE_{01\delta}$ mode, (C) $TE_{01\delta_x}$ mode, which is the second $TE_{01\delta}$ mode, and (D) $TM_{01\delta_y}$ mode, which is the second $TM_{01\delta}$ mode, each of which shows the electromagnetic field distributions using lines of electric force and lines of magnetic force.

Also, Fig. 2 shows electric flux density distribution of the four modes, including the cavity. Here, (A) is a view seen from z-axis direction. (B) is a view seen from y-axis direction. Also, the solid-line arrow indicates a line of electric force. In this manner, a dielectric core 1 is disposed inside cavity 2 having a substantially cubic shape.

In the $TM_{01\delta_x}$ mode, an electric field is directed in the x direction and a magnetic field rotates in a plane parallel to the y-z plane. In this $TM_{01\delta_x}$ mode, an electric field is mainly concentrated onto the $1x$ part, that is, an x-direction part of the dielectric core. The $TM_{01\delta_y}$ mode is at a 90° rotated from the $TM_{01\delta_x}$ mode around the z-axis. That is to say, an electric field is directed in the y direction and a magnetic field rotates in a plane parallel to the x-z plane which is perpendicular to the electric field. In this $TM_{01\delta_y}$ mode, an electric field is mainly concentrated onto the $1y$ part, that is, an y-direction part of the dielectric core.

In the $TE_{01\delta_y}$ mode, an electric field rotates in a

plane perpendicular to the y direction. In this $TE_{01\delta_y}$ mode, an electric field is mainly concentrated onto the $1x$ part, that is, an x -direction part of the dielectric core. The $TE_{01\delta_x}$ mode is at a 90° rotated from the $TE_{01\delta_y}$ mode
5 around the z -axis. That is to say, an electric field rotates in a plane perpendicular to the x direction. In this $TE_{01\delta_x}$ mode, an electric field is mainly concentrated onto the $1y$ part, that is, a y -direction part of the dielectric core.

10 The portion denoted as " P_m " of the dielectric core 1 is a protrusion protruding from the dielectric core 1 toward the inner surface of the cavity 2. The electric flux of the TM mode passes mainly through a capacity portion created between the end face of this dielectric core protrusion P_m
15 and the inner surface of the cavity 2. That is to say, the resonant frequency of the TM mode is determined by the capacity created between the end face of this dielectric core protrusion P_m and the inner surface of the cavity 2. Also, independence of the electric flux of the TM mode
20 passing inside the dielectric core 1 is increased.

As described in detail below, when the $TE_{01\delta_y}$ mode and the $TE_{01\delta_x}$ mode are coupled, the coupling between the $TM_{01\delta_x}$ mode and the $TM_{01\delta_y}$ mode occurs simultaneously in accordance with it.

25 Fig. 4 shows examples in which electric flux densities

of said four resonant modes are obtained by simulation. In this manner, in the $TM_{01\delta_x}$ mode, electric flux runs from the inner surface of the cavity near one end face of the x-direction portion 1x of the dielectric core to the inner
5 surface of the cavity near the other end face.

Fig. 3 is an example using another dielectric core 1. Here, (A) is a view seen from the z-axis direction and (B) is a view seen from the y-axis direction. In the examples shown in Figs. 2 and 4, the $TM_{01\delta_x}$ mode and the $TM_{01\delta_y}$ mode
10 are produced by setting the end faces of the four sides of the dielectric core 1 apart from the inner surface of the cavity 2. However, as shown in Fig. 3, if the end faces of the four sides of the dielectric core 1 are set in contact with the inner surface of the cavity 2, it can be operated
15 as a TM_{011x} mode and a TM_{011y} mode.

Fig. 5 shows a coupling sequence of the four resonant modes described above. In this example, the $TM_{01\delta_x}$ mode and the $TE_{01\delta_y}$ mode are coupled, the $TE_{01\delta_y}$ mode and the $TE_{01\delta_x}$ mode are coupled, and further the $TE_{01\delta_x}$ mode and
20 the $TM_{01\delta_y}$ mode are coupled. Also, at the same time, the coupling between the $TM_{01\delta_x}$ mode and the $TM_{01\delta_y}$ mode is caused not to occur.

Next, a structure for coupling the $TE_{01\delta_y}$ mode and the $TE_{01\delta_x}$ mode without producing the coupling between the
25 $TM_{01\delta_x}$ mode and the $TM_{01\delta_y}$ mode is shown in Fig. 6. Here,

(D) is a side view seen in the y-axis direction, (A) is a sectional view seen on A-A part, (B) is a sectional view taken on B-B part, and (C) is a sectional view seen on C-C part. The dielectric core 1 basically has a three-layer structure. (A), (B), and (C) are sectional views taken on an upper layer La, a middle layer Lb, and a lower layer Lc, respectively. In the upper layer La part, as shown in (A), protrusions Pe1 of the dielectric core protruding in the direction of $x + y$ (in the direction having a direction angle of 45° assuming that the x direction is 0 degree) and in the direction of $-(x + y)$ (in the direction having a direction angle of -135° assuming that the x direction is 0 degree) are formed at the intersection between the x-direction part $1x$ and y-direction part $1y$ of the dielectric core 1. Also, in the lower layer Lc part, as shown in (C), protrusions Pe2 are formed in the same direction. In the middle layer Lb part, as shown in (B), protrusions Pc protruding in the direction of $y - x$ (in the direction having a direction angle of 135° assuming that the x direction is 0 degree) and in the direction of $x - y$ (in the direction having a direction angle of -45° assuming that the x direction is 0 degree) are formed, respectively.

Figs. 7(A) and 7(B) show electric flux density distribution of two coupling modes (TE coupling modes) by the TE01 δ_x mode and the TE01 δ_y mode when the dielectric

core 1 having the structure shown in Fig. 6 is used. Figs. 7(A) and 7(B) show an even-mode electric flux density distribution and an odd-mode electric flux density distribution, respectively. In this case, the protrusions

5 Pe1 of the dielectric core operate to increase the effective dielectric constant of the part through which an even-mode electric flux passes. This also applies to the operation provided by the protrusions Pe2 of the lower layer shown in Fig. 6. As a result, the resonant frequency of the even
10 mode decreases, thereby creating a gap from the resonant frequency of the odd mode and coupling the TE01 δ_x mode and the TE01 δ_y mode.

On the other hand, Fig. 7(C) shows electric flux density distribution of two coupling modes (TM coupling
15 modes) by the TM01 δ_x mode and the TM01 δ_y mode. (C) and (D) show an even-mode electric flux density distribution and an odd-mode electric flux density distribution, respectively. Here, the protrusions Pe1 operate to increase the effective dielectric constant of the part through which an odd-mode
20 electric flux passes. This also applies to the operation provided by the protrusions Pe2 disposed on the lower layer. Accordingly, the resonant frequency of the odd mode decreases, thereby creating a gap from the resonant frequency of the even mode and coupling the TM01 δ_x mode and
25 the TM01 δ_y mode.

However, protrusions P_c are disposed on the middle layer portion of the dielectric core 1 shown in Fig. 6. These protrusions P_c protrude in the 90° -different directions around an z -axis with respect to the protruding directions of the upper layer protrusions P_{e1} and the lower layer protrusions P_{e2} . These protrusions P_c operate in the direction to decrease the resonant frequency of the even mode of the TM coupling mode, contrary to the case shown in Figs. 7(C) and 7(D). As a result, it is possible to make the resonant frequencies of the even mode and the odd mode of the TM coupling mode equal by determining the amounts of the protrusions P_{e1} , P_{e2} , and P_c . That is to say, it is possible to restrain the coupling between the $TM_{01\delta_x}$ mode and the $TM_{01\delta_y}$ mode. Although the protrusions P_c of the dielectric core 1 also give some influence on the TE coupling mode, the influence is less than that on the TM coupling mode, because the electric flux density of the TE coupling mode is relatively higher in the upper part and the lower part than in the middle part of the dielectric core. Accordingly, the protrusions P_c have almost no influence on the amount of coupling between the $TE_{01\delta_x}$ mode and the $TE_{01\delta_y}$ mode.

Taking an advantage of this effect, the amount of the coupling between the $TE_{01\delta_x}$ mode and the $TE_{01\delta_y}$ mode can be determined independently of the coupling between the $TM_{01\delta_x}$

mode and the $TM_{01\delta_y}$ mode by determining the amount of the protrusions Pe_1 , Pe_2 , and P_c of the dielectric core 1.

Here, examples of the changes of the resonant frequency and coupling coefficient of each resonant mode when the amount of the protrusions of the protruding portions disposed at the intersection between the x-direction part and y-direction part of the dielectric core 1 are shown in Figs. 8 and 9. Fig. 8(C) is an example where protrusions P of the dielectric core are formed in the same directions, as shown in Fig. 8(A) and 8(B), in any of the upper layer, the middle layer, and the lower layer of the dielectric core 1, and the amount of protrusions is changed. Here, K_M denotes a coupling coefficient between the $TM_{01\delta_x}$ mode and the $TM_{01\delta_y}$ mode; K_E denotes a coupling coefficient between the $TE_{01\delta_x}$ mode and the $TE_{01\delta_y}$ mode; TE_o denotes a frequency of the odd mode of the TE coupling mode; TE_e denotes a frequency of the even mode of the TE coupling mode; TM_o denotes a frequency of the odd mode of the TM coupling mode; TM_e denotes a frequency of the even mode of the TM coupling mode.

As described above, as the length (the amount of protrusion is expressed by the length of a side) of the protrusion P increases, the amount of coupling of the TE modes with each other increases as well as the amount of coupling of the TM modes with each other simultaneously.

Fig. 8(D) shows a characteristic in the situation where the protrusions P protrude in the same direction, as shown in Fig. 8(A) and 8(B), in the upper layer and the lower layer of the dielectric core 1, whereas the protrusions P in the middle layer of the dielectric core 1 are formed at 90° different directions so that the KM becomes substantially zero. In (C), as the amount of the protrusions of the protrusion P of the dielectric core 1 increases, the resonant frequency of any of TEx, TEy, TMx, and TMy decreases. In contrast, in (D), the frequencies of the TMO and TMe become almost constant. That is to say, the TM01δ_x mode and the TM01δ_y mode do not couple.

Fig. 9 shows an example where, as shown in (A) and (B), protrusions P are disposed at the 180° rotationally opposite positions of the dielectric core 1 around the z-axis (in the direction perpendicular to the page surface) and subsidences S are disposed at the 90° rotational positions around the z-axis. (C) of Fig. 9 shows a characteristic in the case where protrusions P and subsidences S are disposed on any of the upper layer, the middle layer, and the lower layer of the dielectric core 1 in the same directions. (D) shows a characteristic in the case where protrusions P and subsidences S of the upper and the lower layers of the dielectric core 1 are disposed in the same directions, whereas those of the middle layer are disposed at the 90°

different directions, and the amount of the protrusions of the protrusion P and the amount of the subsidences of the subsidence S on the middle layer are determined such that the KM becomes substantially zero.

5 By forming the protrusions and the subsidences in this manner, KE can be made large as shown in (D), and TE_e decreases as TE_o increases. Accordingly, the coupling coefficients of both modes can be determined while keeping each of the frequencies of the basic modes (the TE_{01δ_x} mode
10 and the TE_{01δ_y} mode) substantially constant. Thus, it becomes easy to adjust only the coupling coefficient independently of the resonant frequency.

Fig. 10 is an example in which a dielectric filter consisting of the four-stage resonators utilizing the above-
15 described four resonant modes is constructed. (A) is a plan view with the top surface of the cavity is removed; (B) is a front view with the near-side wall surface of the cavity 2 removed. In Fig. 10, the dielectric core 1 is fixed by
20 adhesion to the central part of the bottom surface of the cavity 2 through a support table 3 having a low dielectric constant. Thus, the dielectric core 1 is disposed substantially at the center of the cavity 2. Coaxial
connectors 5a, 5b are attached to the cavity 2, and the central conductor thereof projects into the inside of the
25 cavity 2 as input/output probes 4a, 4b. The probe 4a is

coupled, through electric field, to the $TM_{01\delta_x}$ mode whose electric flux mainly passes the dielectric core 1 in the x direction. The probe 4b is coupled, through electric field, to the $TM_{01\delta_y}$ mode whose electric flux mainly passes the dielectric core 1 in the y direction.

The coupling between the $TM_{01\delta_x}$ mode and the $TE_{01\delta_y}$ mode and the coupling between the $TE_{01\delta_x}$ mode and the $TM_{01\delta_y}$ mode shown in Fig. 5 are performed by displacing the height of the middle-layer part L_b having a high TM mode electric flux density of the dielectric core 1 upward or downward from the middle height. That is to say, the balance of the electric field strength of the $TM_{01\delta_x}$ mode and the $TM_{01\delta_y}$ mode in the vertical direction collapses, and thus energy moves from the $TM_{01\delta_x}$ mode to the $TE_{01\delta_y}$ mode to produce the coupling between the both modes. Similarly, energy moves from the $TE_{01\delta_x}$ mode to the $TM_{01\delta_y}$ mode to produce the coupling between the both modes.

In this manner, the dielectric resonator device operates as a dielectric filter that is equipped with the four-stage resonators and has a band-pass characteristic.

In this regard, the center of the electric flux distribution of the $TM_{01\delta_x}$ mode and the $TM_{01\delta_y}$ mode can also be displaced upwardly or downwardly by displacing the position of the probes 4a, 4b shown in Fig. 10 in the vertical direction (the z-axis direction) upwardly or

downwardly from the middle height of the dielectric core 1, thereby coupling the $TE_{01\delta_y}$ mode and the $TE_{01\delta_x}$ mode.

Next, the structure of a dielectric filter according to a second embodiment is shown in Fig. 11. Here, protrusions
5 Pe1, Pe2 for the TE coupling of the dielectric core 1 are fillet-shaped. Also, protrusions Pc for restraining the TM coupling are fillet-shaped. In this regard, portions which do not protrude positively (90° rotated positions of Pe1, Pe2, and Pc around the z-axis) are also fillet-shaped such
10 that the dielectric core 1 becomes difficult to crack. The structure is the same as that shown by the first embodiment for the other portions. Accordingly, as in the first embodiment, the dielectric resonator device operates as a dielectric filter that is equipped with the four-stage
15 resonators and has a band-pass characteristic.

Figs. 12 and 13 are diagrams illustrating the configuration of a dielectric filter according to a third embodiment. (A) of Fig. 12 is a plan view of the dielectric core 1 in the cavity 2 and (B) is a front view of the same
20 dielectric core 1. This dielectric core 1 has a structure equal to the structure in which the middle-layer part Lb of the dielectric core 1 shown in Fig. 10 shifted to the lowermost to eliminate the lower-layer part Lc in order to have a two-layer structure consisting of an upper-layer part
25 La and a lower-layer part Lb'. Accordingly, the probes 4a,

4b are also disposed in the central part of the lower-layer part Lb' of the dielectric core 1. Even with this two-layer structure, the $TE_{01\delta_x}$ mode and the $TE_{01\delta_y}$ mode can be coupled by the protrusion of the protrusions Pe for TE coupling, and the coupling between the $TM_{01\delta_x}$ mode and the $TM_{01\delta_y}$ mode can be restrained by the protrusion of the protrusions Pc for restraining the TM coupling. Accordingly, the dielectric resonator device also operates as a dielectric filter consisting of the four-stage resonators. and having a band-pass characteristic.

In the example shown in Fig. 12, protrusions Pm are disposed on the dielectric core 1 for the $TM_{01\delta}$ mode. However, the excitation and the external coupling of the $TM_{01\delta}$ mode can be performed without disposing dielectric core protrusions Pm, as shown in Fig. 13. At that time, as shown in Fig. 13, it is possible to increase independence in the dielectric core 1 of the electric flux of the $TM_{01\delta}$ mode passing through the dielectric core 1 by disposing a flat surface part, which faces the dielectric core 1, on each of the probe 4a and 4b.

Figs. 14 and 15 show the structure of a dielectric filter according to a fourth embodiment. In both figures, (A) is a plan view of the dielectric core 1 inside the cavity 2 and (B) is a front view thereof. The dielectric core 1 used in the dielectric filter according to the fourth

embodiment has an outer cubic shape with subsidences Se on its upper layer part La and subsidences Sc on its lower-layer part Lb' . The subsidences Se formed on the upper-layer part La of the dielectric core 1 creates a difference
5 in the resonant frequencies of the even mode and the odd mode of the TE coupling mode, thereby coupling the $TE_{01\delta_x}$ mode and the $TE_{01\delta_y}$ mode. Also, the subsidences Sc formed on the lower-layer part Lb operates to suppress the shift of the frequencies of the even mode and the odd mode of the TM
10 coupling mode that is caused by the presence of the above-described subsidences Se . Accordingly, it is possible to suppress the coupling between the $TM_{01\delta_x}$ mode and the $TM_{01\delta_y}$ mode by balancing the subsidences Se and Sc .

The example shown in Fig. 15 is the case where the
15 protrusions Pm for the $TM_{01\delta}$ mode formed on the dielectric core 1 in Fig. 14, is eliminated. Using such a dielectric core, the dielectric resonator device operates as a dielectric filter, in the same manner, in which the four-stage resonators are coupled in sequence and which has a
20 band-pass characteristic.

Figs. 16 and 17 are diagrams illustrating the structure of a dielectric filter according to a fifth embodiment. The dielectric core 1 used in this dielectric filter is equal to a structure in which a dielectric core 1 shown in Fig. 14 is
25 modified to have a cylindrical shape. That is to say, the

dielectric core 1 has a substantially cylindrical shape as a whole, forming subsidences S_e for the TE coupling on the upper-layer part L_a , and subsidences S_c for restraining the TM coupling on the lower-layer part L_b' . Also, Fig. 17 is equal to a structure in which the dielectric core protrusions P_m in Fig. 16 are removed. Even using such forms, the dielectric resonator device also operates as a dielectric filter consisting of four-stage resonators and having a band-pass characteristic.

Fig. 18 is a diagram illustrating the configuration of a dielectric filter according to a sixth embodiment. In this example, the dielectric core 1 is cross-shaped in its plan view, and forms subsidences S_e for the TE coupling on the upper-layer part L_a , and subsidences S_c for restraining the TM coupling on the lower-layer part L_b' . Since the subsidences S_e cause a difference in the resonant frequencies of the even mode and the odd mode of the TE coupling mode, the $TE_{01\delta_x}$ mode and the $TE_{01\delta_y}$ mode are coupled by subsidences S_e . Also, the subsidences S_c formed on the lower-layer part L_b operate to restrain the shift of the frequencies of the even mode and the odd mode of the TM coupling mode. Accordingly, it is possible to restrain the coupling between the $TM_{01\delta_x}$ mode and the $TM_{01\delta_y}$ mode by balancing the subsidences S_e and S_c .

Using such a dielectric core, the dielectric resonator

device also operates, in the same manner, as a dielectric filter in which the four-stage resonators are coupled in sequence and which has a band-pass characteristic.

Fig. 19 is a diagram illustrating the configuration of a dielectric filter according to a seventh embodiment. In this example, holes H_e for the TE coupling are formed in the upper layer part of the dielectric core 1 and holes H_c for restraining the TM coupling are formed on the lower-layer part. In this manner, it is possible to cause a difference in effective dielectric constants of the individual parts through which the even-mode and odd-mode electric flux of the TE coupling mode pass and to make the effective dielectric constants of the individual parts through which the even-mode and the odd-mode electric flux of the TM coupling mode pass substantially equal, thereby coupling the $TE_{01\delta_x}$ mode and $TE_{01\delta_y}$ mode without coupling the $TM_{01\delta_x}$ mode and $TM_{01\delta_y}$ mode.

Fig. 20 is a diagram illustrating the configuration of a dielectric filter according to an eighth embodiment. The dielectric core 1 used here is the same dielectric core 1 shown in Fig. 12. However, within the cavity 2, the dielectric core 1 is rotated at 45° around the z-axis. Also, in connection with this, a probe 4a is disposed near the end of the x-direction part $1x$ of the dielectric core and a probe 4b is disposed near the end of the y-direction part $1y$

of the dielectric core. Note that although the portions of the dielectric core denoted by $1x$ and $1y$ are not oriented in the x -direction and y -direction, respectively, the same reference numerals are used in order to correspond to the reference numerals shown in Fig. 12. Here, the TM mode whose electric flux mainly passes through the $1x$ portion of the dielectric core 1 can be denoted as the $TM_{01\delta}(x + y)$ mode, the TM mode whose electric flux mainly passes through the $1y$ portion of the dielectric core 1 can be denoted as the $TM_{01\delta}(x - y)$ mode. Further, the TE mode whose electric field rotates in the $1x$ portion can be denoted as the $TE_{01\delta}(x + y)$ mode, and the TE mode whose electric field rotates in the $1y$ portion can be denoted as the $TE_{01\delta}(x - y)$ mode.

The $TE_{01\delta}(x + y)$ mode and the $TE_{01\delta}(x - y)$ mode can be coupled by the protrusion of the protrusions P_e for the TE coupling, and the coupling between the $TM_{01\delta}(x + y)$ mode and the $TM_{01\delta}(x - y)$ mode due to the above-described protrusions P_e can be suppressed by the protrusion of the protrusions P_c for the TM coupling suppression. Accordingly, the dielectric resonator device of this example also operates as a dielectric filter consisting of the four-stage resonators and having a band-pass characteristic.

Next, the configuration of a composite dielectric filter is shown in Fig. 21 as a ninth embodiment. Here, the

portions denoted as Rtx and Rrx include the dielectric filter shown in Fig. 20, respectively. Probes 4tx, 4rx respectively couple with one of the TM01 δ modes of the resonators Rtx, Rrx through an electric field. Also, probe 5 4ant couples with the other TM01 δ mode of the resonators Rtx, Rrx, respectively. Here, the probe 4ant performs a phase adjustment such that a transmission signal does not sneak in the reception filter side and a reception signal does not sneak in the transmission filter side. Here, by setting the 10 frequency of each resonant mode, the composite dielectric filter operates on the whole as a transmitter/receiver with a coaxial connector 5tx as a transmission-signal input part, 5rx as a reception-signal output part, 5ant as an antenna connection part, Rtx as a transmission filter, and Rrx as a 15 reception filter.

Next, the configuration of a communication apparatus according to a tenth embodiment is shown in Fig. 22 as a block diagram. Here, the transmitter/receiver shown in Fig. 21 is used for a duplexer. A transmission circuit and 20 a receiving circuit are connected to the transmission-signal input port and the reception-signal output port of the duplexer, respectively. An antenna is connected to an antenna port. In this manner, a communication apparatus equipped with a multimode dielectric resonator device 25 according to the present invention is constituted.

According to this present invention, a difference in frequency arises between the even-mode and the odd-mode, which are the two coupling modes of the first and the second TE_{01δ} modes, thereby causing the coupling of the first and the second TE_{01δ} modes. Also, no difference in frequency arises between the even-mode and the odd-mode, which are the two coupling modes of the first and the second TM_{01δ} modes or TM₀₁₁ modes, thereby causing no coupling of the first and the second TM_{01δ} modes or TM₀₁₁ modes among themselves.

That is to say, the coupling of the first and the second TE_{01δ} modes themselves can be set independently of TM modes.

Also, according to this invention, with regard to the even mode and the odd mode of the TE coupling modes, a difference is created in the amount of a protrusion or the amount of a subsidence of the dielectric core portions having electric flux passing therethrough and a subsidence or a protrusion that cancels the frequency changes, caused by said difference, of the even mode and the odd mode of the TM coupling modes is provided in the dielectric core portion having a relatively low electric flux density of the TE coupling mode. Thus, a frequency change of the even mode and the odd mode of the TM coupling mode, which arises from the difference in the amount of protrusion or the amount of subsidence of the dielectric core disposed on the position having a high electric flux density of the TE coupling mode,

is canceled, and the coupling of the first and the second TM01 δ or TM011 modes themselves can be prevented.

Also, according to this invention, the first and the second TM01 δ modes or TM011 modes and the first and the second TE01 δ modes are coupled, respectively, by displacing a center of electric flux density distribution of the first and the second TM01 δ modes or the first and the second TM011 modes upwardly or downwardly in planes perpendicular to the directions of the electric fields of the first and the second TM01 δ modes or the first and the second TM011 modes. At this time, since the coupling does not arise between the first and the second TM01 δ modes or the TM011 modes themselves, the first TM01 δ mode or TM011 mode \rightarrow the first TE01 δ mode \rightarrow the second TE01 δ mode \rightarrow the second TM01 δ mode or TM011 mode are coupled in sequence, thereby operating as four-stage resonators.

Also, according to this invention, a dielectric filter can be used as a small-sized band-pass filter by providing: a multimode dielectric resonator device operating as the four-stage resonators described above; and external coupling means for external coupling of the first-stage and the last-stage resonators, respectively, of the four-stage resonators.

Also, according to this invention, by providing two sets of the dielectric filters described above and sharing one of the external coupling means of each of the dielectric

filters, for example, the dielectric filter can be used as a small-sized transmitter/receiver having one of the filters as a transmission filter, the other of the filters as a reception filter, and the shared external coupling means as
5 an antenna port.

Also, according to this invention, a small-sized communication apparatus having a predetermined high-frequency circuit characteristic can be constituted by providing the above-described dielectric filter or composite
10 dielectric filter in a high-frequency circuit portion.